Notice of References Cited Application/Control No. 10/716,445 Examiner David M. Naff Applicant(s)/Patent Under Reexamination SCHAEFER ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,972,703	10-1999	Long et al.	435/372
	В	US-			
	С	US-			
	D	US-			
	ш	US-			
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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